Interference Scarch

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	472	(((single adj crystal) same (coat\$6 or film or layer)) same (wafer or substrate or support\$6 or base or semiconductor) same (remov\$6 or replac\$6)).clm.	US-PGPUB; USPAT	OR	ON	2006/04/13 18:03
L3	13	2 and ((test\$6 or valida\$6 or calibrat\$6 or check\$6 or monitor\$6 or inspect\$6 or verif\$6).clm.)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/04/13 18:07